**ON Semiconductor** 

Is Now

# Onsemi

To learn more about onsemi<sup>™</sup>, please visit our website at <u>www.onsemi.com</u>

onsemi and ONSEMI. and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product factures, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and asfety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or by customer's technical experts. onsemi products and actal performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use onsemi products for any such unintended or unauthorized application, Buyer shall indemnify and hold onsemi and its officers, employees, subsidiari

## MOSFET - SiC Power, Single N-Channel, TO247-4L

650 V, 12 mΩ, 142 A

# NTH4L015N065SC1

#### Features

- Typ.  $R_{DS(on)} = 12 \text{ m}\Omega @ V_{GS} = 18 \text{ V}$ Typ.  $R_{DS(on)} = 15 \text{ m}\Omega @ V_{GS} = 15 \text{ V}$
- Ultra Low Gate Charge ( $Q_{G(tot)} = 283 \text{ nC}$ )
- High Speed Switching with Low Capacitance (C<sub>oss</sub> = 430 pF)
- 100% Avalanche Tested
- $T_J = 175^{\circ}C$
- These Devices are Pb-Free and are RoHS Compliant

#### **Typical Applications**

- SMPS (Switching Mode Power Supplies)
- Solar Inverters
- UPS (Uninterruptable Power Supplies)
- Energy Storages

#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage			V <sub>DSS</sub>	650	V
Gate-to-Source Voltage			V <sub>GS</sub>	-8/+22	V
	Recommended Operation Values T <sub>C</sub> < 175°C of Gate-to-Source Voltage		V <sub>GSop</sub>	-5/+18	V
Continuous Drain Current (Note 1)	Steady T <sub>C</sub> = 25°C State		Ι <sub>D</sub>	142	A
Power Dissipation (Note 1)			PD	500	W
Continuous Drain Current (Note 1)	Steady State	T <sub>C</sub> = 100°C	۱ <sub>D</sub>	100	A
Power Dissipation (Note 1)			PD	250	W
Pulsed Drain Current (Note 2)	T <sub>C</sub> = 25°C		I <sub>DM</sub>	483	A
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	–55 to +175	°C
Source Current (Body Diode)			I <sub>S</sub>	114	А
Single Pulse Drain-to-Source Avalanche Energy ( $I_{L(pk)} = 13 \text{ A}, L = 1 \text{ mH}$ ) (Note 3)			E <sub>AS</sub>	84	mJ
Maximum Lead Temperature for Soldering (1/8" from case for 5 s)			ΤL	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

 The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
 Description to the particular conditions noted.

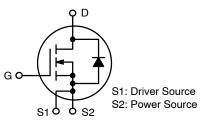
- 2. Repetitive rating, limited by max junction temperature.
- 3. EAS of 84 mJ is based on starting  $T_J$  = 25°C; L = 1 mH,  $I_{AS}$  = 13 A,  $V_{DD}$  = 50 V,  $V_{GS}$  = 18 V.



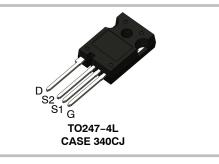
## **ON Semiconductor®**

#### www.onsemi.com

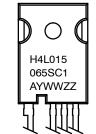
V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX		
650 V	18 mΩ @ 18 V	142 A		



N-CHANNEL MOSFET



#### MARKING DIAGRAM



H4L015065SC1 = Specific Device Code

A = Assembly Location

WW = Work Week

ZZ = Lot Traceability

#### **ORDERING INFORMATION**

Device	Package	Shipping
NTH4L015N065SC1	TO247-4L	30 Units / Tube

#### THERMAL CHARACTERISTICS

Parameter	Symbol	Max	Unit
Junction-to-Case - Steady State (Note 1)	$R_{\theta JC}$	0.3	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	40	

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA		650	-	-	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	$I_D = 20 \text{ mA}$ , referenced to $25^{\circ}\text{C}$		-	0.12	-	V/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$	-	-	10	μA
		$V_{DS} = 650 \text{ V}$ $T_{J} = 175^{\circ}\text{C}$		_	-	1	mA
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{GS} = +22/-8$ V, $V_{DS}$	s = 0 V	-	-	250	nA
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 25 \text{ m}$	ıΑ	1.8	2.5	4.3	V
Recommended Gate Voltage	V <sub>GOP</sub>			-5	-	+18	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 15 V, I <sub>D</sub> = 75 A, T <sub>J</sub> = 25°C		-	15	-	mΩ
		V <sub>GS</sub> = 18 V, I <sub>D</sub> = 75 A	, T <sub>J</sub> = 25°C	-	12	18	
		V <sub>GS</sub> = 18 V, I <sub>D</sub> = 75 A	, T <sub>J</sub> = 175°C	_	16	-	
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 75 A		_	47	-	S
CHARGES, CAPACITANCES & GATE RES	SISTANCE						
Input Capacitance	C <sub>ISS</sub>	$V_{GS}$ = 0 V, f = 1 MHz, $V_{DS}$ = 325 V		_	4790	-	pF
Output Capacitance	C <sub>OSS</sub>			_	430	-	
Reverse Transfer Capacitance	C <sub>RSS</sub>			_	33	-	
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = -5/18 V, $V_{DS}$ = 520 V, I <sub>D</sub> = 75 A		_	283	-	nC
Gate-to-Source Charge	Q <sub>GS</sub>			_	72	-	
Gate-to-Drain Charge	Q <sub>GD</sub>			-	64	-	
Gate-Resistance	R <sub>G</sub>	f = 1 MHz		_	1.6	-	Ω
SWITCHING CHARACTERISTICS		1					
Turn-On Delay Time	t <sub>d(ON)</sub>	V <sub>GS</sub> = -5/18 V,		_	23	-	ns
Rise Time	t <sub>r</sub>	V <sub>DS</sub> = 400 V, I <sub>D</sub> = 75 A,		_	26	-	-
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$\bar{R}_{G} = 2.2 \Omega$		-	49	-	
Fall Time	t <sub>f</sub>	inductive load		_	9.6	-	
Turn–On Switching Loss	E <sub>ON</sub>			_	167	-	μJ
Turn-Off Switching Loss	E <sub>OFF</sub>			_	276	-	
Total Switching Loss	E <sub>tot</sub>		_	443	-		
SOURCE-DRAIN DIODE CHARACTERIS		1			1		L
Continuous Source-Drain Diode Forward Current	I <sub>SD</sub>	V <sub>GS</sub> = -5 V, T <sub>J</sub> = 25°C		-	-	114	A
Pulsed Source-Drain Diode Forward Current (Note 2)	I <sub>SDM</sub>			-	-	483	

 $V_{GS}$  = –5 V,  $I_{SD}$  = 75 A,  $T_J$  = 25°C

4.8

\_

V

\_

 $\mathsf{V}_{\mathsf{SD}}$ 

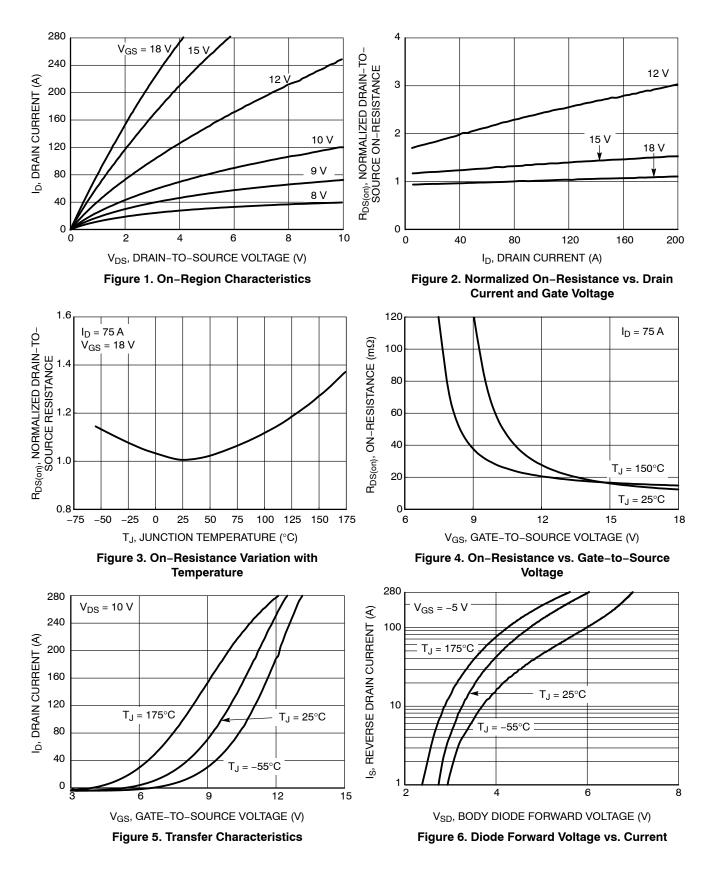
Forward Diode Voltage

#### **ELECTRICAL CHARACTERISTICS** ( $T_J$ = 25°C unless otherwise specified) (continued)

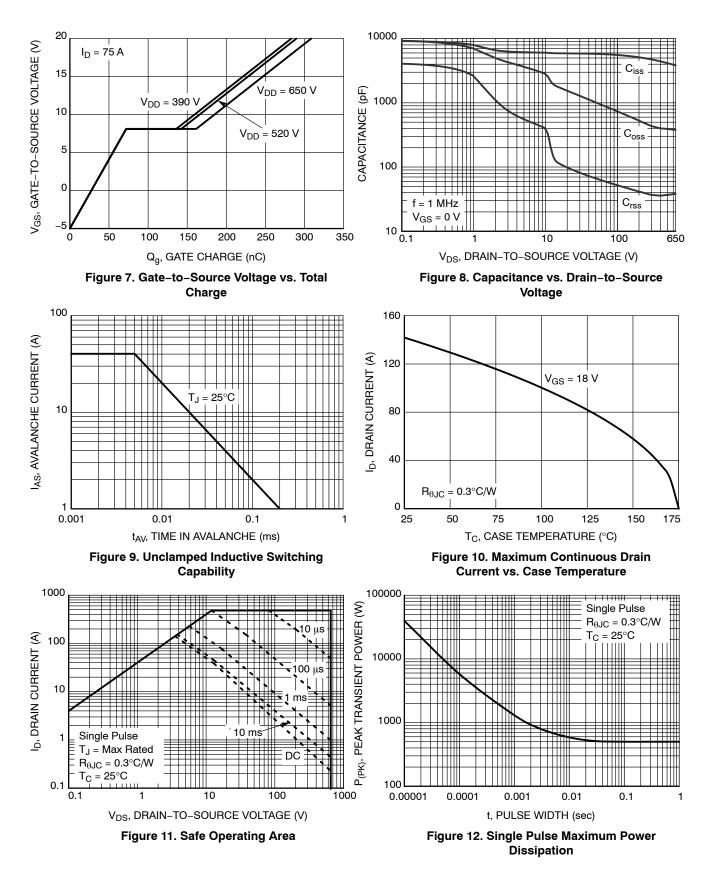
Parameter	Symbol	Test Condition	Min	Тур	Max	Unit		
SOURCE-DRAIN DIODE CHARACTERISTICS								
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = -5/18 V, I <sub>SD</sub> = 75 A, dI <sub>S</sub> /dt = 1000 A/μs	-	28	-	ns		
Reverse Recovery Charge	Q <sub>RR</sub>	αl <sub>S</sub> /αt = 1000 A/μs	-	234	-	nC		
Reverse Recovery Energy	E <sub>REC</sub>		-	23	-	μJ		
Peak Reverse Recovery Current	I <sub>RRM</sub>		-	16	-	А		
Charge time	Ta		-	17	-	ns		
Discharge time	Tb	]	-	11	-	ns		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL CHARACTERISTICS**



#### **TYPICAL CHARACTERISTICS**



#### **TYPICAL CHARACTERISTICS**

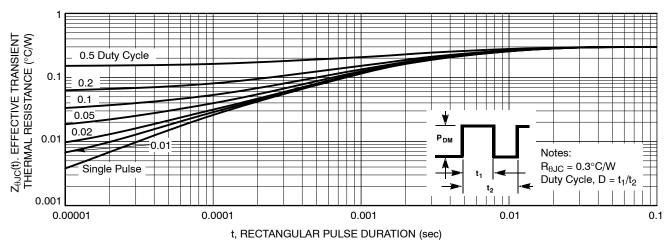
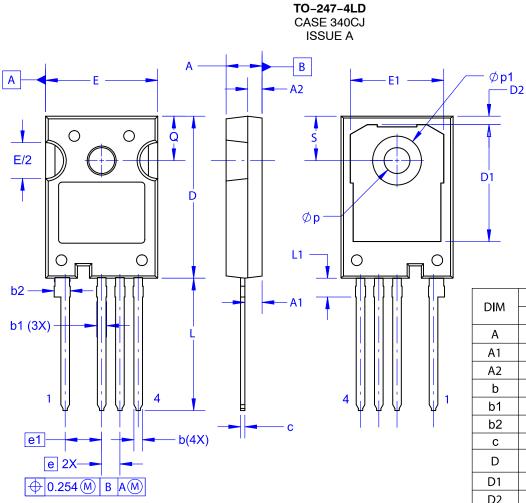


Figure 13. Junction-to-Case Thermal Response

#### PACKAGE DIMENSIONS



NOTES:

- A. NO INDUSTRY STANDARD APPLIES TO THIS PACKAGE.
  B. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
  C. ALL DIMENSIONS ARE IN MILLIMETERS.
  D. DRAWING CONFORMS TO ASME Y14.5-2009.

	1					
DM	MILLIMETERS					
DIM	MIN	NOM	MAX			
А	4.80	5.00	5.20			
A1	2.10	2.40	2.70			
A2	1.80	2.00	2.20			
b	1.07	1.20	1.33			
b1	1.20	1.40	1.60			
b2	2.02	2.22	2.42			
С	0.50	0.60	0.70			
D	22.34	22.54	22.74			
D1	16.00	16.25	16.50			
D2	0.97	1.17	1.37			
е	2.54 BSC					
e1	Ę	5.08 BSC	2			
Е	15.40	15.60	15.80			
E1	12.80	13.00	13.20			
E/2	4.80	5.00	5.20			
L	18.22	18.42	18.62			
L1	2.42	2.62	2.82			
р	3.40	3.60	3.80			
p1	6.60	6.80	7.00			
Q	5.97	6.17	6.37			
S	5.97	6.17	6.37			

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent-Marking.pdf</u>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor hy such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, a

#### PUBLICATION ORDERING INFORMATION

#### LITERATURE FULFILLMENT:

#### TECHNICAL SUPPORT

ON Semiconductor Website: www.onsemi.com

Email Requests to: orderlit@onsemi.com

North American Technical Support: Voice Mail: 1 800–282–9855 Toll Free USA/Canada Phone: 011 421 33 790 2910 Europe, Middle East and Africa Technical Support: Phone: 00421 33 790 2910 For additional information, please contact your local Sales Representative